Search Notes

Application/Control No.	Applicant(s)/Patent unde Reexamination	r
10/780,690	HABU ET AL.	
Examiner	Art Unit	
Richard L. Chiesa	1724	

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Class	Subclass	Date	Examiner	
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INTERFERENCE SEARCHED				
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
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PALM Inventors' Names and Assignee (Walbro Japan, Inc.) searches.	9/28/2005	RLC
ABOVE	,	
UPDATED.	12/6/05	R. Z.C.
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